

Design of
Engineering
Experiments

#### CHAPTER OUTLINE

- 7-1 THE STRATEGY OF EXPERIMENTATION
- 7.2 FACTORIAL EXPERIMENTS
- 7-3 2k FACTORIAL DESIGN
  - 7-3.1 22 Design
  - 7-3.2 Statistical Analysis
  - 7-3.3 Residual Analysis and Model Checking
  - 7-3.4  $2^k$  Design For  $k \ge 3$  Factors
  - 7-3.5 Single Replicate of a 2<sup>k</sup> Design
- 7-4 CENTER POINTS AND BLOCKING IN 2<sup>k</sup> DESIGNS
  - 7-4.1 Addition of Center Points
  - 7-4.2 Blocking and Confounding

#### 7-5 FRACTIONAL REPLICATION OF A 2<sup>k</sup> DESIGN

- 7-5.1 One-Half Fraction of a 2<sup>k</sup> Design
- 7-5.2 Smaller Fractions:
- 2<sup>k-p</sup> Fractional Factorial Designs
- 7-6 RESPONSE SURFACE METHODS AND DESIGNS
  - 7-6.1 Method of Steepest Ascent
  - 7-6.2 Analysis of a Second-Order Response Surface
- 7-7 FACTORIAL EXPERIMENTS WITH MORE THAN TWO LEVELS

#### LEARNING OBJECTIVES

After careful study of this chapter, you should be able to do the following:

- 1. Design and conduct engineering experiments involving several factors using the factorial design approach.
- 2. Know how to analyze and interpret main effects and interactions.
- Understand how the ANOVA is used to analyze the data from these experiments.
- 4. Assess model adequacy with residual plots.
- 5. Know how to use the two-level series of factorial designs.
- 6. Understand the role of center points and how two-level factorial designs can be run in blocks.
- 7. Design and analyze two-level fractional factorial designs.

### 7-1 Why Design Experiments

- 1. Reduce design and development time
- 2. Improve design via a systematic analysis of variables and their effect on the yield
- 3. Reduce cost of operations

#### **Applications**

- 1. Evaluate design configurations
- 2. Material selection
- 3. Determination of critical parameters that has the most effect on the process or gives the best process performance

### 7-1 The Strategy of Experimentation

Every experiment involves a sequence of activities:

- 1. Conjecture the original hypothesis that motivates the experiment.
- 2. Experiment the test performed to investigate the conjecture.
- 3. Analysis the statistical analysis of the data from the experiment.
- 4. Conclusion what has been learned about the original conjecture from the experiment. Often the experiment will lead to a revised conjecture, and a new experiment, and so forth.

By a factorial experiment we mean that in each complete replicate of the experiment all possible combinations of the levels of the factors are investigated.

Table 7-1 A Factorial Experiment without Interaction

	Factor B		
Factor A	$B_{ m low}$	$B_{ m high}$	
$A_{ m low}$	10	20	
$A_{ m high}$	30	40	

Table 7-2 A Factorial Experiment with Interaction

	Factor B			
Factor A	$B_{ m low}$	$B_{ m high}$		
$A_{ m low}$	10	20		
$A_{ m high}$	30	0		

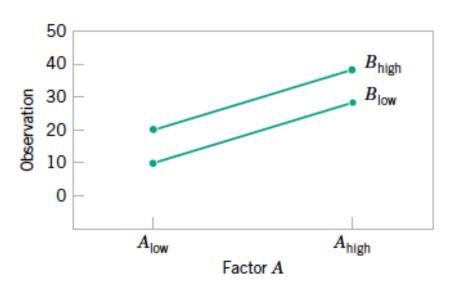


Figure 7-1 An interaction plot of a factorial experiment, no interaction.

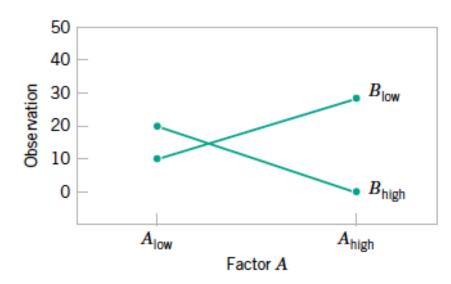


Figure 7-2 An interaction plot of a factorial experiment, with interaction.

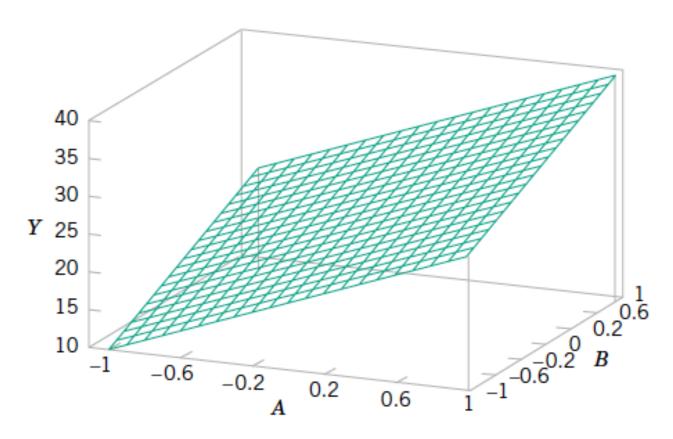


Figure 7-3 Three-dimensional surface plot for the data from Table 7-1, showing main effects of the two factors *A* and *B*.

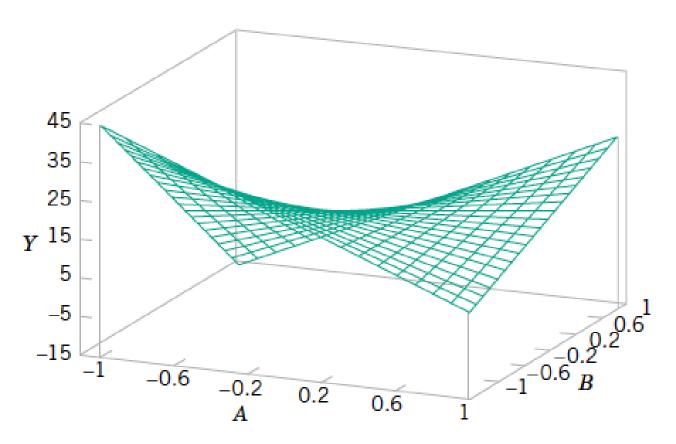


Figure 7-4 Three-dimensional surface plot for the data from Table 7-2, showing the effect of the *A* and *B* interaction.

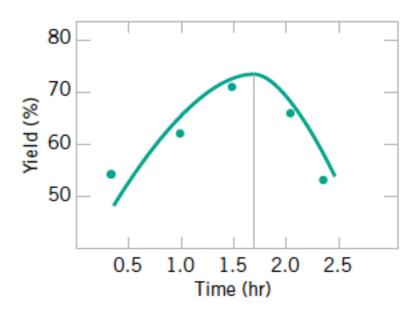


Figure 7-5 Yield versus reaction time with temperature constant at 155°F.

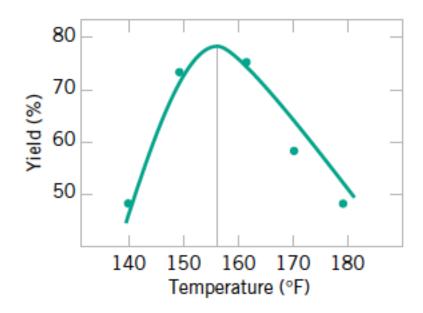


Figure 7-6 Yield versus temperature with reaction time constant at 1.7 hours.

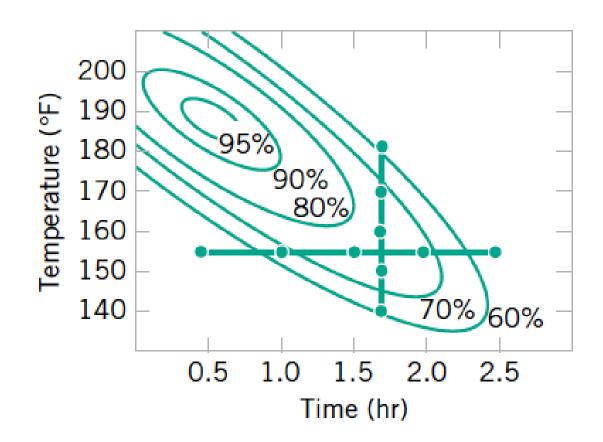


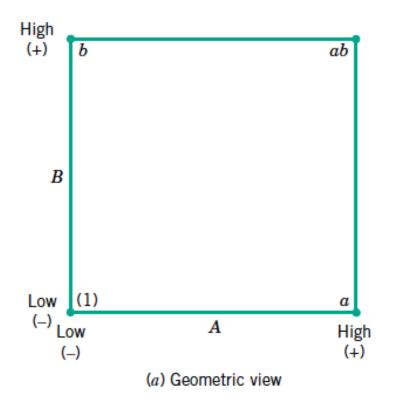
Figure 7-7 Contour plot of a yield function and an optimization experiment using the one-factor-at-a-time method.

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**Two** Levels and 'k' variables (or factors)  $\longrightarrow$   $2^k$ 

- OBasic building block
- OAllows to test a range of variables
- OAssumes a linear response

#### 7-3.1 2<sup>2</sup> Example: 2 factors (variables) at 2 levels



Factor						
Run	$\boldsymbol{A}$	В	Label			
1	-	_	(1)			
2	+	_	a			
3	-	+	b			
4	+	+	ab			

Figure 7-8 The 2<sup>2</sup> factorial design.

(b) Design or test matrix for the 2<sup>2</sup> factorial design

Variables (ie. factors): A, B Levels: High (+1); Low (-1)<sup>13</sup>

#### **7-3.1 2**<sup>2</sup> **Example**

$$A = \overline{y}_{A+} - \overline{y}_{A-} = \frac{a+ab}{2n} - \frac{b+(1)}{2n} = \frac{1}{2n} \left[ a+ab-b-(1) \right]$$
 (7-1)

$$B = \overline{y}_{B+} - \overline{y}_{B-} = \frac{b+ab}{2n} - \frac{a+(1)}{2n} = \frac{1}{2n} [b+ab-a-(1)]$$
 (7-2)

$$AB = \frac{ab + (1)}{2n} - \frac{a+b}{2n} = \frac{1}{2n} \left[ ab + (1) - a - b \right]$$
 (7-3)

#### **7-3.1 2**<sup>2</sup> **Example**

$$A = \overline{y}_{A+} - \overline{y}_{A-} = \frac{a+ab}{2n} - \frac{b+(1)}{2n} = \frac{1}{2n} \left[ a+ab-b-(1) \right]$$
 (7-1)

$$Contrast_A = a + ab - b - (1)$$

#### **7-3.1 2**<sup>2</sup> **Example**

Table 7-3 Signs for Effects in the 2<sup>2</sup> Design

Treatment	Factorial Effect					
Combination	I	$\boldsymbol{A}$	В	AB		
(1)	+	_	_	+		
a	+	+	_	_		
$\boldsymbol{b}$	+	<del>_</del>	+	_		
ab	+	+	+	+		

#### EXAMPLE 7-1

#### **Epitaxial Process**

An article in the AT&T Technical Journal (Vol. 65, March/April 1986, pp. 39–50) describes the application of two-level factorial designs to integrated circuit manufacturing. A basic processing step in this industry is to grow an epitaxial layer on polished silicon wafers. The wafers are mounted on a susceptor and positioned inside a bell jar. Chemical vapors are introduced through nozzles near the top of the jar. The susceptor is rotated, and heat is applied. These conditions are maintained until the epitaxial layer is thick enough.

Table 7-4 presents the results of a  $2^2$  factorial design with n=4 replicates using the factors A= deposition time and B= arsenic flow rate. The two levels of deposition time are -= short and += long, and the two levels of arsenic flow rate are -=55% and +=59%. The response variable is epitaxial layer thickness ( $\mu$ m). Find the estimate of the effects and assess the importance of the effects.

Table 7-4 The 2<sup>2</sup> Design for the Epitaxial Process Experiment

Treatment	Fac	torial E	ffect						Thickness (m	m)
Combination	A	В	AB	Thickness (μm)				Total	Average	Variance
(1)	_	_	+	14.037	14.165	13.972	13.907	56.081	14.020	0.0121
a	+	_	_	14.821	14.757	14.843	14.878	59.299	14.825	0.0026
b	_	+	_	13.880	13.860	14.032	13.914	55.686	13.922	0.0059
ab	+	+	+	14.888	14.921	14.415	14.932	59.156	14.789	0.0625 17

#### EXAMPLE 7-1

**Solution.** We find the estimates of the effects using equations 7-1, 7-2, and 7-3 as follows:

$$A = \frac{1}{2n} [a + ab - b - (1)]$$

$$= \frac{1}{2(4)} [59.299 + 59.156 - 55.686 - 56.081] = 0.836$$

$$B = \frac{1}{2n} [b + ab - a - (1)]$$

$$= \frac{1}{2(4)} [55.686 + 59.156 - 59.299 - 56.081] = -0.067$$

$$AB = \frac{1}{2n} [ab + (1) - a - b]$$

$$= \frac{1}{2(4)} [59.156 + 56.081 - 59.299 - 55.686] = 0.032$$

**Practical interpretation:** The numerical estimates of the effects indicate that the effect of deposition time is large and has a positive direction (increasing deposition time increases thickness), because changing deposition time from low to high changes the mean epitaxial layer thickness by  $0.836 \mu m$ . The effects of arsenic flow rate (B) and the AB interaction appear small.

#### Effect of variables

- 1. Standard Error of effects
- 1. Regression analysis of effects
- 1. Normal probability plot analysis of effects

#### 7-3.2 Statistical Analysis

#### **Standard Error of the Effects**

$$V(\text{Effect}) = \frac{\sigma^2}{N/2} + \frac{\sigma^2}{N/2} = \frac{2\sigma^2}{N/2} = \frac{\sigma^2}{n2^{k-2}}$$

$$\hat{\sigma}_i^2 = \frac{\sum_{j=1}^n (y_{ij} - \bar{y}_{i.})^2}{(n-1)} \qquad i = 1, 2, \dots, 2^k$$

$$\hat{\sigma}^2 = \sum_{i=1}^{2^k} \frac{\hat{\sigma}_i^2}{2^k}$$

# 7-3.2 Statistical Analysis Standard Error of the Effects

To illustrate this approach for the epitaxial process experiment, we find that

$$\hat{\sigma}^2 = \frac{0.0121 + 0.0026 + 0.0059 + 0.0625}{4} = 0.0208$$

and the estimated standard error of each effect is

$$se(Effect) = \sqrt{[\hat{\sigma}^2/(n2^{k-2})]} = \sqrt{[0.0208/(4 \cdot 2^{2-2})]} = 0.072$$

Table 7-5 t-Tests of the Effects for Example 7-1 Epitaxial Process Experiment

Effect	Effect Estimate	Estimated Standard Error	t Ratio	<i>P</i> -Value	Effect ± Two Estimated Standard Errors
$\boldsymbol{A}$	0.836	0.072	11.61	0.00	$0.836 \pm 0.144$
$\boldsymbol{B}$	-0.067	0.072	-0.93	0.38	$-0.067 \pm 0.144$
AB	0.032	0.072	0.44	0.67	$0.032 \pm 0.144$

#### **Regression Analysis of effects**

$$Y = \beta_0 + \beta_1 x_1 + \beta_2 x_2 + \beta_{12} x_1 x_2 + \epsilon$$

For Example 7-1, the least squares fitted model is

$$\hat{y} = 14.389 + \left(\frac{0.836}{2}\right)x_1 + \left(\frac{-0.067}{2}\right)x_2 + \left(\frac{0.032}{2}\right)x_1x_2$$

Deposition time  $(x_1 \Rightarrow \pm 1)$ ; Arsenic flow  $(x_2 \Rightarrow \pm 1)$ ; Interaction  $(x_1x_2)$ 

#### Formulas for Two-Level Factorial Experiments with k Factors Each at Two Levels and N Total Trials

Coefficient = 
$$\frac{\text{effect}}{2}$$
  
 $se(\text{Effect}) = \sqrt{\frac{2\hat{\sigma}^2}{N/2}} = \sqrt{\frac{\hat{\sigma}^2}{n2^{k-2}}}$   
 $se(\text{Coefficient}) = \frac{1}{2}\sqrt{\frac{2\hat{\sigma}^2}{N/2}} = \frac{1}{2}\sqrt{\frac{\hat{\sigma}^2}{n2^{k-2}}}$  (7-7)  
 $t \text{ ratio} = \frac{\text{effect}}{se(\text{effect})} = \frac{\text{coefficient}}{se(\text{coefficient})}$   
 $\hat{\sigma}^2 = \text{mean square error}$   
 $2^k(n-1) = \text{residual degrees of freedom}$ 

Table 7-6 Regression Analysis for Example 7-1. The regression equation is Thickness =  $14.4 + 0.418x_1 - 0.0336x_2 + 0.0158x_1x_2$ 

		. 1 2	1 2		
Independent Variable	Coefficient Estimate	Standard of Coeffic		$t \text{ for } H_0$ $\text{Coefficient} = 0$	<i>P</i> -Value
Intercept	14.3889	0.0360	)	399.17	0.000
A or $X_1$	0.41800	0.0360	)5	11.60	0.000
$B \text{ or } X_2$	-0.03363	0.0360	)5	-0.93	0.369
$AB$ or $X_1X_2$	0.01575	0.0360	)5	0.44	0.670
		Analysis of V	/ariance		
Source	Sum of Squares	Degrees of Freedom	Mean Square	$f_{\circ}$	<i>P</i> -Value

	Analysis of Variance							
Source	Sum of Squares	Degrees of Freedom	Mean Square	$f_0$	<i>P</i> -Value			
Model	2.81764	3	0.93921	45.18	0.000			
Error	0.24948	12	0.02079					
Total	3.06712	15						

t-test shows that the effect of 'B' and 'AB' on yield is not significant

# Table 7-7

#### ANOVA (Table 7-7 contd.)

Source of Variation	Sum of Squares	Degree of Freedom	Mean Square	$f_0$	<i>P</i> -Value
A (deposition time)	2.7956	1	2.7956	134.40	7.07 E-8
B (arsenic flow)	0.0181	1	0.0181	0.87	0.38
$\overrightarrow{AB}$	0.0040	1	0.0040	0.19	0.67
Error	0.2495	12	0.0208		
Total	3.0672	15			

#### 7-3.3 Residual Analysis and Model Checking

From Example 7-1,

$$\hat{y} = 14.389 + \left(\frac{0.836}{2}\right) x_1$$

when  $x_1 = -1$ :

$$\hat{y} = 14.389 + \left(\frac{0.836}{2}\right)(-1) = 13.971 \,\mu\text{m}$$

The resulting residuals are:

$$e_1 = 14.037 - 13.971 = 0.066$$
  $e_3 = 13.972 - 13.971 = 0.001$   $e_2 = 14.165 - 13.971 = 0.194$   $e_4 = 13.907 - 13.971 = \frac{1}{26}0.064$ 

# Error Analysis

Low Deposition Time  $(x_1) = -1$  and Low Arsenic flow rate -> row (1)

Low Deposition Time  $(x_1) = -1$  and High Arsenic flow rate -> row (1)

High Deposition Time  $(x_1) = +1$  and Low Arsenic flow rate -> row (1)

High Deposition Time  $(x_1) = +1$  and Low Arsenic flow rate -> row (1)

#### 7-3.3 Residual Analysis and Model Checking

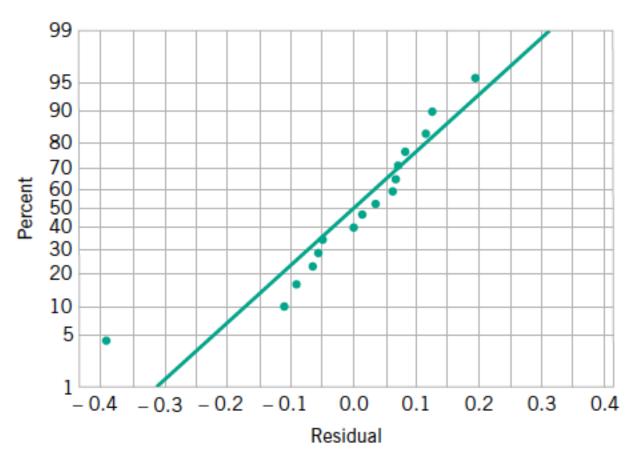


Figure 7-9 Normal probability plot of residuals for the epitaxial process experiment.

Recall: Sec 3-6.1 100[1-(j-0.5)/n]

#### 7-3.3 Residual Analysis and Model Checking

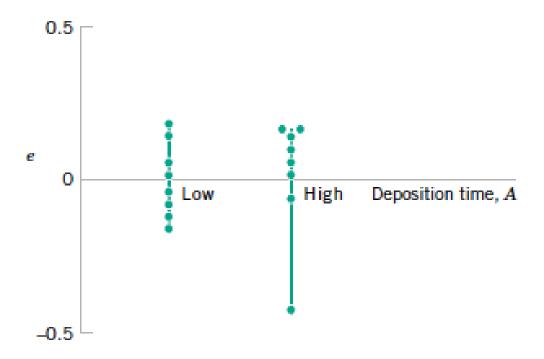


Figure 7-10 Plot of residuals versus deposition time.

#### 7-3.3 Residual Analysis and Model Checking

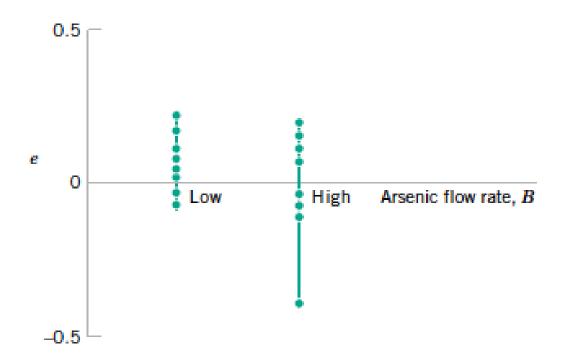
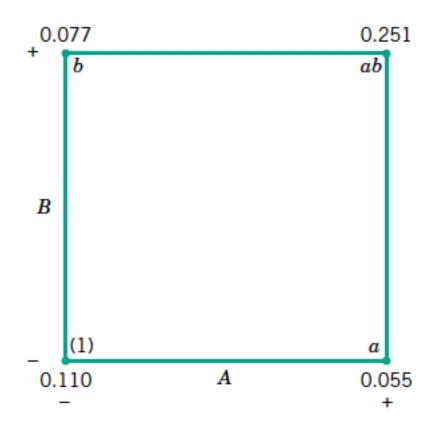


Figure 7-11 Plot of residuals versus arsenic flow rate.

#### 7-3.3 Residual Analysis and Model Checking



Ref. Table 7-4

Figure 7-12 The standard deviation of epitaxial layer thickness at the four runs in the 2<sup>2</sup> design.